Computational Intelligence Application in Electrical Engineering

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Message from the Guest Editors

This Special Issue aims to give opportunities for presenting computational intelligence application in a wide spectrum of electrical engineering fields, from power systems and electrical machines to electronics, electromagnetic fields, and electromagnetic compatibility (EMC) calculations. Therefore, researchers are welcome to submit details of their research in the areas of modeling, estimation, optimization, control, and simulation in electrical engineering using computational intelligence techniques and methods.

Special Issue

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Message from the Editor-in-Chief

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